* PATENT APPLICATION

FORM PTO-1449	ATTY. DKT NO.	49-001-TN	SER NO 5 33911		
	APPLICANT	Christian Pfau			
	FILING DATE	May 5, 2005	GROUP 3742		

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
PL	US 2003/192161 A1 (Corresponding to DE 10024 423 A1 which is discussed on page 1 of the spec.)	10/16/2003	Voss et al.		
PL	US 2001/042295 A1 (Corresponding to DE 10024 423 A1 which is discussed on page 1 of the spec.)	11/22/2001	Voss et al.		
PL	5,356,245	10/18/1994	Hosoi et al.		

FOREIGN PATENT DOCUMENTS

TRANSLATION

	 								2111011	
	DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES		NO Eng.	
	 							ļ	Abstract	
PL	JP-A-1-109029	4/26/89	JAPAN						x	
PL	DE 20119639 U	4/17/03	GERMANY					х		
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* Full English text is available in machine-translated form in JPO (Japanese Patent Office) English language web site at http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX.

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

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EXAMINER	/Pł	nilip Leung/	DATE CONSIDERED	08/04/2006

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